



Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450101-02921	SERIAL NO. 09/830,858
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	APPLICANT Tetsujiro KONDO et al.	
	FILING DATE May 1, 2001	GROUP 2622

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AD						
	AE						
	AF						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)		
/Y.A./	AG	TOYAMA K ET AL: "Wallflower: principles and practice of background maintenance" COMPUTER VISION, 1999. THE PROCEEDINGS OF THE SEVENTH IEEE INTERNATIONAL CONFERENCE ON KERKYRA, GREECE 20-27 SEPT. 1999, LOS ALAMITOS, CA, USA, IEEE COMPUT. SOC, US, 20 September 1999 (1999-09-20), pages 255-261, XP010350430 ISBN: 9-7695-0164-8
/Y.A./	AH	DINSTEIN I: "A NEW TECHNIQUE FOR VISUAL MOTION ALARM" PATTERN RECOGNITION LETTERS, NORTH-HOLLAND PUBL. AMSTERDAM, NL, vol. 8, no. 5, 1 December 1988 (1988-12-01), pages 347-351, XP000118647 ISSN: 0167-8655
/Y.A./	AI	BASCLE B ET AL: "MOTION DEBLURRING AND SUPER-RESOLUTION FROM AN IMAGE SEQUENCE" EUROPEAN CONFERENCE ON COMPUTER VISION, BERLIN, DE, vol. 2, 1996, pages 573-582, XP008025986
/Y.A./	AJ	ANDREW J PATTI ET AL: "Superresolution Video Reconstruction with Arbitrary Sampling Lattices and Nonzero Aperture Time" IEEE TRANSACTIONS ON IMAGE PROCESSING, IEEE SERVICE CENTER, PISCATAWAY, NJ, US, vol. 6, no. 8, August 1997 (1997-08), XP011026196 ISSN: 1057-7149
/Y.A./	AK	IRANI M ET AL: "Image Sequence enhancement using multiple motions analysis" PROCEEDINGS OF THE COMPUTER SOCIETY CONFERENCE ON COMPUTER VISION AND PATTERN RECOGNITION. CHAMPAIGN, IL, JUNE 15 - 18, 1992, NEW YORK, IEEE, US, 15 June 1992 (1992-06-15), pages 216-221, XP010029353 ISBN: 0-8186-2855-3

EXAMINER	/Yogesh Aggarwal/	DATE CONSIDERED	03/16/2008
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.